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Issued date : September 29, 2011

Revised date : December 7, 2011 FCC ID : AZD214

# RADIO TEST REPORT

Test Report No.: 31CE0052-HO-01-I

**Applicant** 

Canon Inc.

**Type of Equipment** 

Wireless Module

Model No.

CH9-1225

AZD214

FCC ID

**Test regulation** 

FCC Part15 Subpart C: 2011

Test result

: **Complied** 

- 1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the limits of the above regulation.
- 4. The test results in this test report are traceable to the national or international standards.
- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by any agency of the Federal Government.
- 6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.

Date of test:

May 20 to June 25, 2011

Representative test engineer:

Shinichi Takano Engineer of WiSE Japan, UL Verification Service

Approved by:

Go Ishiwata Manager of WiSE Japan, UL Verification Service

RTL02610

The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan. There is no testing item of "Non-accreditation".

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# **SECTION 1: Customer information**

Company Name : Canon Inc.

Address : 30-2, Shimomaruko, 3-chome, Ohta-ku, Tokyo, 146-8501 Japan

Telephone Number : +81 3 3757 6798 Facsimile Number : +81 3 3757 8431 Contact Person : Kiyoshi Sahoyama

# **SECTION 2:** Equipment under test (E.U.T.)

# 2.1 Identification of E.U.T.

Type of Equipment : Wireless Module Model No. : CH9-1225

Serial No. : Refer to 4.2 in this report.

Rating : DC3.3V Receipt Date of Sample : May 9, 2011 Country of Mass-production : Japan

Condition of EUT : Production prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No modification by the test lab.

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### 2.2 Product description

Model: CH9-1225 (referred to as the EUT in this report) is a Wireless Module.

**General specification** 

Clock frequency(ies) in the system : 38.4MHz, 32.768kHz

**Radio specification** 

Equipment type : Transceiver

Antenna type : Planar Inverted F Antenna

Antenna connector type : U.FL

Operation temperature range : -20 to +70 deg.C.

**Bluetooth** 

Frequency of operation : 2402-2480MHz Bandwidth / Channel spacing : 79MHz & 1MHz

Type of modulation : FHSS
Antenna gain with cable loss : 1.95dBi
ITU code : F1D, G1D

Wireless LAN\*

Frequency of operation : 2412-2462MHz (IEEE 802.11b, 11g, 11n-HT20)

2422-2452MHz (IEEE 802.11n-HT40) 5180-5320MHz (IEEE 802.11a, 11n-HT20) 5190-5310MHz (IEEE 802.11n-HT40) 5745-5825MHz (IEEE 802.11a, 11n-HT20) 5755-5795MHz (IEEE 802.11n-HT40)

Bandwidth & channel spacing : Bandwidth :

20MHz (IEEE 802.11b, 11g, 11a, 11n-HT20), 40MHz (IEEE 802.11n-HT40)

Channel spacing:

5MHz (2.4GHz), 20MHz (5GHz)

Type of modulation : DSSS (IEEE 802.11b)

OFDM (IEEE 802.11a/g/n)

Antenna gain with cable loss : +1.95 dBi (2400/2450/2500MHz)

-1.32 dBi (5160/5250/5340MHz) -0.43 dBi (5725/5785/5845MHz)

ITU code : D1D, G1D

### FCC Part15.31 (e)

The Wireless Module is provided with stable power supply DC 3.3V from the host device and has power supply regulator which provides DC 2.85V and DC 1.8V, therefore, the equipment complies power supply regulation.

### FCC Part15.203

The EUT has a unique coupling/antenna connector (U.FL). Therefore the equipment complies with the requirement of 15.203.

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<sup>\*</sup> Refer to the test report 31CE0052-HO-01-J/K/L for this function.

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# **SECTION 3: Test specification, procedures & results**

### 3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2011, final revised on July 8, 2011

and effective August 8, 2011

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.209 Radiated emission limits, general requirements

Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz,

and 5725-5850MHz

The EUT has been tested for compliance with FCC Part 15 Subpart B: 2011. Refer to the test report 31CE0052-SH-03-B.

### 3.2 Procedures & Results

Item	Test Procedure	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.4:2003 7. AC powerline conducted emission measurements	FCC Section 15.207	-	N/A	21.2dB Freq.: 0.40233MHz Detector: Quasi-Peak Phase: N Mode: Tx 2441MHz, 3DH5	Complied
Carrier frequency separation	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A		Complied
20dB bandwidth	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A		-
Number of hopping frequency	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A	*See data.	Complied
Dwell time	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A		Complied
Maximum peak output power	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (b)(1)	Conducted	N/A		Complied
Band edge compliance & Spurious emission	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (d) Section15.209	Conducted/ Radiated	N/A	4.1dB Freq.: 12400.000MHz Detector: Average Polarization: Vertical Mode: Tx 2480MHz, 3DH5	Complied

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<sup>\*</sup>The revision on July 8, 2011 does not affect the test specification applied to the EUT.

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### 3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results	
Occupied Bandwidth (99%)	ANSI C63.4:2003 13. Measurement of intentional radiators, RSS-Gen 4.6.1	RSS-Gen 4.6.1	Conducted	-	-	
Note: UL Japan's EMI Work Procedures No.13-EM-W0420 and 13-EM-W0422.						

<sup>\*</sup> Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC*1/SR*2 (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) AMN/LISN	150kHz-30MHz	3.6 dB	3.6 dB	3.6 dB
Radiated emission	9kHz-30MHz	3.7 dB	3.7 dB	3.6 dB
(Measurement distance: 3m)	30MHz-300MHz	4.9 dB	5.1 dB	5.0 dB
	300MHz-1GHz	5.0 dB	5.2 dB	5.0 dB
	1GHz-13GHz	4.8 dB	4.8 dB	4.9 dB
Radiated emission	13GHz-18GHz	5.6 dB	5.6 dB	5.6 dB
(Measurement distance: 1m)	18GHz-40GHz	4.8 dB	4.3 dB	4.4 dB

<sup>\*1:</sup> SAC=Semi-Anechoic Chamber

### **Conducted emission test**

The data listed in this test report has enough margin, more than site margin.

### Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

### Antenna port conducted test

Power Measurement uncertainty above 1GHz for this test was: (±) 1.9dB

Spurious emission (Conducted) Measurement (below 1GHz) uncertainty for this test was: (±) 1.8dB

Spurious emission (Conducted) Measurement (1G-3GHz) uncertainty for this test was: (±) 2.3dB

Spurious emission (Conducted) Measurement (3G-18GHz) uncertainty for this test was: (±) 3.6dB

Spurious emission (Conducted) Measurement (18G-26.5GHz) uncertainty for this test was: (±) 4.0dB

Bandwidth Measurement uncertainty for this test was: (±) 5.4%

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<sup>\*2:</sup> SR= Shielded Room is applied besides radiated emission

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### 3.5 Test location

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JAB Accreditation No. : RTL02610

	FCC Registration No.	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
☐ No.1 Semi-anechoic chamber	697847	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
☑ No.2 Semi-anechoic chamber	697847	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
☐ No.3 Semi-anechoic chamber	697847	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
☐ No.4 Full-anechoic chamber	-	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
☐ No.1 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
☑ No.2 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
☐ No.3 shielded room	-	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
☐ No.4 shielded room	-	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
☐ No.5 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
☑ No.6 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-

# 3.6 Test setup, Data of test & Test instruments

Refer to Appendix 1 to 3.

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# **SECTION 4: Operation of E.U.T. during testing**

### 4.1 Operating mode

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test item	Operating mode	Tested frequency
Conducted emission	Transmitting Hopping OFF (DH5/3DH5) Payload: PRBS9	2402MHz, 2441MHz, 2480MHz
Carrier frequency separation Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9		-
20dB bandwidth Transmitting Hopping OFF (DH5/3DH5)/Inquiry, Payload: PRBS9		2402MHz, 2441MHz, 2480MHz
Number of hopping frequency	Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9	-
Dwell time	Transmitting (Hopping ON), Payload: PRBS9 -DH1, -DH3, -DH5 -3DH1, -3DH3, -3DH5 -Inquiry	-
Maximum peak output power	Transmitting (Hopping OFF), Payload: PRBS9 -DH5, -2DH5, -3DH5	2402MHz, 2441MHz, 2480MHz
Band edge compliance & Spurious emission	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON -Hopping OFF	Band edge compliance: 2402MHz, 2480MHz
(Conducted)		Spurious emission:
(Radiated)	Transmitting (DH5/3DH5), Payload: PRBS9	2402MHz, 2441MHz, 2480MHz
99% occupied bandwidth	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON -Hopping OFF	2402MHz, 2441MHz, 2480MHz

<sup>\*</sup>As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload (except Dwell time test).

However, the limit level 125mWof AFH mode was used for the test.

\*EUT has the power settings by the software as follows;

Power settings: 4dBm Software: Tera Term v4.69

**Justification:** The system was configured in typical fashion (as customer would normally use it) for testing.

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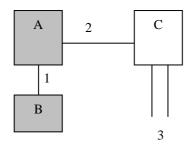
<sup>\*</sup>Remarks: Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT.

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# 4.2 Configuration and peripherals



<sup>\*</sup> Test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless Module	CH9-1225	*1)	CANON	EUT
В	Antenna	Dual Band WLAN Antenna Cable Assembly 2011	001	Tyco Electronics	EUT
C	Extender	TSS-T6	-	CANON	-

<sup>\*1)</sup> ES4101: Conducted emission and Radiated emission, ES4006: Other test

### List of cables used

No.	Name	Length (m)	Shield (Cable)	Shield (Connector)	Remarks
1	Antenna	0.025	Unshielded	Unshielded	-
2	Jig	0.04	Unshielded	Unshielded	-
3	DC	1.5	Unshielded	Unshielded	+3.3V, G

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# **SECTION 5: Conducted emission**

#### 5.1 **Operating environment**

The test was carried out in No.2 shielded room.

Temperature: Refer to test data (APPENDIX 2) Humidity Refer to test data (APPENDIX 2)

#### 5.2 **Test configuration**

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane.

The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from LISN and excess AC cable was bundled in center.

Photographs of the set up are shown in Appendix 1.

#### 5.3 **Test conditions**

Frequency range 0.15 - 30MHz **EUT** position Table top

#### 5.4 **Test procedure**

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a screened room. The EUT was connected to a Line Impedance Stabilization Network (LISN) via DC power supply.

An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, an average detector.

The conducted emission measurements were made with the following detector of the test receiver.

Detector Type Quasi-Peak/ Average

IF Bandwidth 9kHz

#### 5.5 **Results**

Summary of the test results: Pass

Refer to APPENDIX 2

# **SECTION 6:** Carrier frequency separation

# Test procedure

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass

Refer to APPENDIX 2

# SECTION 7: 20dB bandwidth & Occupied bandwidth (99%)

# **Test procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass

Refer to APPENDIX 2

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# **SECTION 8: Number of hopping frequency**

### Test procedure

The Number of Hopping Frequency was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results:

Pass

Refer to APPENDIX 2

# **SECTION 9: Dwell time**

### **Test procedure**

The Dwell time was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results:

Pass

Refer to APPENDIX 2

# **SECTION 10: Maximum peak output power**

### Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

Summary of the test results:

Pass

Refer to APPENDIX 2

# **SECTION 11: Spurious emissions (Antenna port conducted)**

### **Test procedure**

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement. In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)

Summary of the test results:

Pass

Refer to APPENDIX 2

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# **SECTION 12: Radiated emission**

### 12.1 Operating environment

The test was carried out in No.2 Semi-Anechoic Chamber.

Temperature : See test data (APPENDIX 2)
Humidity : See test data (APPENDIX 2)

### 12.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane.

The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 1.

### 12.3 Test conditions

Frequency range : 30MHz to 26.5GHz

Test distance : 3m (below 13GHz) / 1m (above 13GHz)

EUT position : Table top

### 12.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane and at a distance of 3m (below 13GHz) / 1m (above 13GHz). Measurements were performed with quasi-peak, peak and average detector. The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detection of the test receiver and Spectrum Analyzer.

Frequency : 30-1000MHz 1000-26500MHz

Detection Type : Quasi-Peak Peak \* Average

IF Bandwidth : 120kHz RBW:1MHz/VBW:3MHz RBW:1MHz/VBW:See data

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

### Worst position:

	Frequency	Carrier	Spurious			
			30M-1GHz	1-13GHz	13-18GHz	18-26.5GHz
EUT Antenna	Horizontal	Y	X	X	X	X
	Vertical	X	X	X	X	X
M . J. I .	Horizontal	X	X	X	X	Z
Module	Vertical	Z	X	Y	Y	Z

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<sup>\*</sup> When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

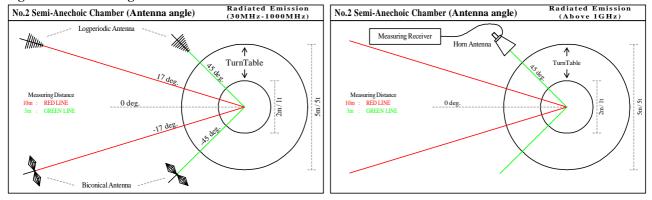
<sup>\*</sup> The VBW was based on the inverse of the duty cycle (Refer to Appendix 2).

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Figure 1. Antenna angle



# 12.5 Band edge

Band edge level at 2400MHz is less than 20dB of peak point of the carrier. Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209. Refer to the data.

### 12.6 Results

Summary of the test results: Pass \*No noise was detected above the 6th order harmonics.

Refer to APPENDIX 2

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# **Contents of appendixes**

# **APPENDIX 1: Photographs of test setup**

Conducted emission Radiated emission Pre-check of the worst position

# **APPENDIX 2: Test data**

Conducted emission
20dB bandwidth and Carrier frequency separation
Number of hopping frequency
Dwell time
Maximum peak output power
Radiated emission
Spurious emission (Antenna port conducted)
99% Occupied bandwidth

# **APPENDIX 3:** Test instruments

Test instruments

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